

VLSI and Computers

PROCEEDINGS

Edited by Walter E. Proebster and Hans Reiner

VLSI and Computers

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Table of Contents

Conference Committee	iii
I. THE IMPACT OF VLSI ON COMPUTERS	
Impact of VLSI on Computers	2
<i>R.V. Latin</i>	
Fault-Tolerant Architectures	
Redundancy and Fault-Tolerance Aspects in VLSI Processing Architectures	3
<i>M. Sami and R. Negrini</i>	
Hardening VLSI Microprogrammed Units Against Transient Failures	8
<i>A. Antola, R. Negrini, M. Sami, and N. Scarabottolo</i>	
Fault-Tolerant Atomic Action Processor Model	15
<i>D. Dacev, D. Andonov, and L.J. Gruerski</i>	
Associative Processors and Memories	
Associative Processors and Memories: Overview and Current Status	19
<i>K. Waldschmidt</i>	
The Application of VLSI Content-Addressable Memories to the Acceleration of Logic Programming Systems	27
<i>J.V. Oldfield, C.D. Stormon, and M. Brule</i>	
A VLSI Concept for an Adaptive Associative Matrix Based on Neural Networks	31
<i>U. Rueckert, I. Kreuzer, and K. Goser</i>	
The Basic Memory Support for Functional Languages	35
<i>Y.H. Ng and R.J. Glover</i>	
Defect Tolerant Components	
VLSI and Navigation Systems	41
<i>Ph. Hartl</i>	
The VLSI Implementation of a Fault-Tolerant and Easily-Testable Associative Memory	47
<i>K.E. Grosspietsch, H. Huber, and A. Mueller</i>	
Computations on a Defective Processor Array	51
<i>M.S. Lee and G. Frieder</i>	
Design of Self-Testing VLSI Components	56
<i>J.P. Hayes</i>	
WSI and Systolic Array Processors	
Reconfiguration of VLSI Arrays: An Index Mapping Approach	60
<i>F. Lombardi, M.G. Sami, and R. Stefanelli</i>	
The Use of a VLSI Sorter Coprocessor to Find the Convex Hull	66
<i>A. Perez, M.A. Abidi, and D.W. Bouldin</i>	
A Control Flow Concept for High Speed Monolithic Digital Signal Processors	70
<i>R. Ernst</i>	
A VLSI Oriented Computer Science Study for the FGCS	74
<i>T. Ichiko</i>	
Signal Processing Architectures	
VLSI Signal Processors: Architectures and Applications	78
<i>P. Vary</i>	
An Efficient Reconfigurable VLSI Array (Preliminary Version)	84
<i>D. Reisis and V.K. Prasanna Kumar</i>	

Emerging Architectures

On the VLSI Realization of Complex Instruction Sets Using RISC-Like Components	88
<i>K. Ghose</i>	
Benefits of an Architecture Implementation; CPU and Cache Complex; For High Performance; In a Very Large Chip	92
<i>G. Boudon and Y. Yamour</i>	
RPM: A Fast RISC Type Prolog Machine	95
<i>C.Y. Cheng, C. Chen, and H.C. Fu</i>	

Multiprocessors

Aspects of Multiprocessor Systems: A Brief Survey and New Concepts	99
<i>W.H. Burkhardt</i>	
The Design of a Problem-mesh	106
<i>J. Staunstrup, F. Barrett, M. Greenstreet, and P. Møller-Nielsen</i>	
A Representation Basis for the Expression of Communication Times of Algorithms Expressed in Terms of Computation Graphs	109
<i>M. Yasrebi, J.C. Browne, and D.P. Agrawal</i>	

Distributed Systems and Multiprocessors

A Global Model of Parallel Processing and Its Implementation	113
<i>D. Jesshope</i>	
A Highly Parallel Computer in Wafer Scale Integration	117
<i>M.J. Chung, E.J. Toy, and A. Gupta</i>	
AI Problem Solving Oriented Multiple Microcomputers Architecture	121
<i>F. Tong</i>	

Image Processing Architectures I

The Gap Between Software Implementation and Hardware Realization of Image Processing	126
<i>H. Kazmierczak</i>	
Designing Parallel VLSI Architectures for Low-Level Image Processing Applications	132
<i>A. Krikelis</i>	
Image Processing Architectures	138
<i>V. Buzuloin</i>	

Image Processing Architectures II

VLSI Implementation of Picture Coding for Variable Rate Transmission	142
<i>T.J.M. Rossiter and D.R. Donovan</i>	
VLSI Convolvers for Computer Vision	148
<i>A. Perez</i>	
VLSI Architecture for Curve Detection	152
<i>H.D. Cheng and C. Tong</i>	
The Impact of VLSI on the Algorithm Design for Multidimensional Convolutions	156
<i>J.-L. Wu and S.-C. Pei</i>	

Emerging Architectures

Two-Dimensional Cellular Automata as VLSI Function Blocks and Their Computer Applications	160
<i>Ph. Tsalides, A. Thanailakis, H.C. Card, and W. Pries</i>	
WASP: A WSI Bit-Serial Processor	164
<i>J.G. Delgado-Frias and I. Contreras</i>	

VLSI Architecture for Direct Prolog Language Interpretation	168
<i>P. Civera, G. Piccinini, and M. Zamboni</i>	
An Enhanced Floating-Point Processor for VLSI Implementation of Parallel Algorithms	173
<i>H.C. Fu and K.T. Sun</i>	

Poster Session I

Parallel Architectures for VLSI Full Custom Devices in Signal Processing and Sensing	177
<i>B.C. Cardarilli, R. Lojaco, S. Sacchetta, M. Salerno, and A. Salsano</i>	
Architecture for Fault-Tolerant Distributed Computer Systems Based on Concepts of Artificial Intelligence	179
<i>J.R. Just and E. Eberbach</i>	
VLSI Impact on Fast Multiplier Architecture	181
<i>S.-E. Chang and J. Singh Bedi</i>	
Design of the Systolic Array OCSAMO	183
<i>A.A. Abdel Kader</i>	
Fault-Tolerant FFT Systems	185
<i>M. Tsunoyama, S. Naito, and M. Uenoyama</i>	

2. THE INFLUENCE OF COMPUTERS ON VLSI

The Influence of Computers on VLSI	187
<i>J.P. Mucha</i>	

Logic and System Simulation I

Multilevel Simulation Techniques	188
<i>F.J. Rammig</i>	
A Fast Timing Analysis Tool for VLSI	193
<i>S. Heinkle</i>	
A Mixed Level Simulation System for VLSI Logic Designs	196
<i>W. Roesner</i>	
Functional Simulation of VLSI Architectures	200
<i>E. Di Zitti, G. Corsini, F. Curatelli, and G.M. Bisio</i>	

Logic and System Simulation II

A Distributed Modeling Approach for Simulation and Verification of Digital Designs	204
<i>S. Ghosh</i>	
Delay Synthesis for Specific MSI/LSI Devices	211
<i>S.A. Black and G.E. Taylor</i>	
YNCC _{FLT} : A New Algorithm for Filtering and Comparing Different But Logically Equivalent VLSI Networks	215
<i>Y. Shiran</i>	
Event-Driven Functional Evaluation of Temporal Expressions in Concurrent Mixed Mode Simulation	219
<i>G. Cabodi, P. Camurati, and P. Prinetto</i>	

Circuit and Interconnection Simulation I

Toggle: A Circuit Analyzer for MOSFET VLSI	224
<i>T.J. Cockerill, H.Y. Hsieh, J. LeBlanc, D. Ostapko, A.E. Ruehli, and J.K. White</i>	
Circuit Decompilation in the SPICE-PAC Package of Simulation Subroutines	229
<i>W.M. Zuberek</i>	
Time Domain Simulation of Signal Propagation on VLSI Interconnect Systems Treating Linear Load Capacitors as Lines	233
<i>H. Grabinski</i>	
Correction Formula and LTE-Estimation for Trapezoidal Rule	238
<i>B. Klaassen and K.L. Paap</i>	

Circuit and Interconnection Simulation II

Timing Analysis and Verification of Digital MOS Circuits	242
<i>M.R. Dagenais and N.C. Rumin</i>	
Circuit Simulation on Vectorprocessors	246
<i>U. Feldmann, K.-G. Rauh, and K. Steger</i>	
Fast Design and Optimization of CMOS Circuits	250
<i>G.L. Bertino, A. Boffa, G. Conte, and V. Daniele</i>	
Functional Design Verification by Register Transfer Net Extraction from Integrated Circuit Layout Data	254
<i>W. Nebel and R.W. Hartenstein</i>	

Hierarchical Design and Silicon Compiler I

A Hierarchical Data Structure for Hardware System Description	258
<i>M. Ancona, A. Clematis, L. De Florian, and E. Puppo</i>	
A Modular Synthesis Technique for Automated VLSI Design	262
<i>J.G. Linders, M. Balakrishnan, A.K. Majumdar, D.K. Banerji, and J.C. Majithia</i>	
Computer Aided Synthesis of VLSI Systems by AI Techniques	268
<i>W. Rosensteil</i>	

Hierarchical Design and Silicon Compiler II

Database Support for VLSI-Design: The Damascus Approach	272
<i>K.R. Dittrich, A.M. Kotz, and J.A. Muelle</i>	
Separation of Hierarchies in VLSI Design	277
<i>L. Spaanenburgh, C. Huijs, and J. Llenstra</i>	
Prolog as a Formalism for Systolic Architectures	281
<i>D. Snyers and A. Thayse</i>	
Linking VLSI Designs with A-38	285
<i>M.R. Greenstreet and J. Staunstrup</i>	
The ALGIC Silicon Compiler Project: New Synthesis Algorithms and Design Experience	289
<i>M. Glesner, H. Joepen, J. Schuck, and N. Wehn</i>	

Logic Synthesis and Design Languages I

Synthesis of Structures and Logic Under VLSI Conditions	293
<i>J.A.G. Jess</i>	
Timing Correction in Logic Synthesis	299
<i>B. Kick</i>	
Relations + Higher Order Functions = Hardware Descriptions	303
<i>M. Sheeran and G. Jones</i>	
Mechanically Derived Systolic Solutions to the Algebraic Path Problem	307
<i>C.-H. Huang and Ch. Lengauer</i>	

Logic Synthesis and Design Languages II

A Hardware Design Language for Logic Simulation and Synthesis in VLSI	311
<i>W. Roesner</i>	
Automated Cascade Partitioning of Combinatorial Logic	315
<i>V. Dvorak</i>	
Transformational Development of Digital Circuit Descriptions: A Case Study	319
<i>C. Delgado Kloos and W. Dosch</i>	
LOVE: A Universal Logic Design Program for Finite State Machines	323
<i>W. Grass and J. Lohse</i>	

Device Modelling and Simulation

The Impact of Computers on Semiconductor Device Modeling	327
<i>H.K. Dirks</i>	
Time-Dependent Simulation of a Dynamic RAM Cell	333
<i>R. Guerrieri, P. Ciampolini, A. Gnudi, M. Rudan, and G. Bagcarani</i>	
SEDSIM: A New Dynamic and Static Device Simulator	337
<i>M. Razaz</i>	
Optimization of Drain Current and Small Signal Conductance of Analytical MOS Models for Analog Circuit Simulation	341
<i>B. Lemaitre and H.L. Zapp</i>	

Design for Testability

Built-In Self-Testing	345
<i>T.W. Williams</i>	
A Standard Method to Increase the Testability of OCMS (the BILBO) of VLSI-6000 Technology and Add Pseudo-Fault Injection	349
<i>D. Kroft</i>	
A Self-Testing CMOS Signal Processor	358
<i>M.J. Ohletz, M. Boehmer, and M. Zimmermann</i>	
Analysis and Design of Repairable PLAs	363
<i>C.-L. Wey and F. Lombardi</i>	

Test Program and Test Pattern Generation and Fault Simulation I

Trends in Test Generation and Fault Simulation	367
<i>C. Vivier</i>	
Bounds on Aliasing Errors in Linear Feedback Shift Registers	373
<i>T.W. Williams, W. Daehn, M. Gruetzner, and C.W. Starke</i>	
Test Generation for VLSI Designs Using Functional Fault Simulation	378
<i>G.M. Silberman and I. Spillinger</i>	
Automatic Test Pattern Generation and Fault Grading in Combinational Circuits	382
<i>M.H. Schulz</i>	

Test Program and Test Pattern Generation and Fault Simulation II

Test Generation for Physical Faults in MOS VLSI Circuits	386
<i>I. Hajj and F. Najm</i>	
Testing a Microprogrammed Control Unit	390
<i>A. Aharon, I. Berger, E. Gofman, and M. Yoeli</i>	
On Parameters Affecting ATPG Performance	394
<i>A. Liou and M. Mezzalana</i>	
Effect of Modelled Faults and a Unified Design of PLAs for Easy Testability	398
<i>R. Sharma and T.N. Rajashekhara</i>	
An Approach to Modular Test Generation Based on the Transparency of Modules	403
<i>M. Marhofer</i>	

Hardware Accelerators

The Application of Hardware Accelerators in VLSI Design	407
<i>A.P. Ambler, N. Coleman, R.L. Manning, and N. Muhammed</i>	
Integration of a Simulation Accelerator for Design and Test	415
<i>S.R. Hansen</i>	
DAPMAC: Design-Rule Checking Using DAP	422
<i>C.C. Jong, A.J. Pearmain, and P.R. Coward</i>	
An Associative Processor as a Design Rule Check Accelerator	426
<i>M. Strugala, D. Tavangarian, K. Waldschmidt, and G. Roll</i>	

Knowledge-Based CAD/CAT Tools I

Automatic Generation of Controller Systems from Control Software	432
<i>R.M. Marshall</i>	
An Expert System Approach to Implement and Verify Synchronous Sequential Circuits	436
<i>J.P. Tsai, B.K. Mirmira, G. Narayanaswami, and K.Y. Fang</i>	
Knowledge-Based Selection of Self-Test Techniques in Computer-Aided Designing of Self-Testing VLSI Circuits	440
<i>A. Krasniewski</i>	
Knowledge Based Systems for CAD, CAT, and CAR: Reality or Utopia?	444
<i>P. Camurati and P. Prinetto</i>	

Knowledge-Based CAD/CAT Tools II

SIMUEVA: A CAD Program Package for Efficient Analysis of Simulation Results	451
<i>R. Buschke and K. Lagemann</i>	
On Guaranteed Correct Digital Designs	455
<i>B.J.F. van Beijnum, J. Smit, S.H. Gerez, and S.M. Heemstra</i>	
Integrated "CAD" System Based on Heterogeneous Computers and Multiple Heuristic Algorithms	459
<i>E. Shragowitz, J. Lee, S. Sabni, and L. Lin</i>	

Knowledge-Based CAD/CAT Tools III

CMOS VLSI Book Library and Array Macros Based on Sub-Circuit Elements	463
<i>O. Wagner</i>	
An Automatic Placer for Arbitrary Sized Rectangular Blocks Based on a Cellular Model	466
<i>D.L. Jarmou</i>	
The IGSIC-System: A CAD Tool for VLSI Design	471
<i>D. Hartert, Th. Knieriemer, and E.v. Puttkamer</i>	
AI Concepts for VLSI Process Modelling and Monitoring	474
<i>K.M. Marks and K.F. Goser</i>	

Poster Session II

Test Pattern Generation for Synchronous Sequential Circuits	478
<i>I.M. Bell and G.E. Taylor</i>	
Modular Built-In Testprocessor for VLSI-Chips	480
<i>V. Blaschke, W. Budde, and A. Hunger</i>	
Cascade Shifting and Its Efficiency for VLSI-Testability Design	482
<i>A. Blum</i>	
RUBICON: A Design Rule Adaption System for Nonorthogonal IC Layouts	484
<i>R. Brueck, G. Schrammeck, and J. Waterkamp</i>	
Design of Self-Checking VLSI Elementary Cells for DSP Applications	486
<i>G.C. Cardarilli, R. Lojaco, M. Salerno, S. Sacchetta, and A. Salsano</i>	
Logic Testability Analysis Using Bipartite Graphs	489
<i>B. Castagnolo and F. Corsi</i>	
The Impact of Expert Systems on Design	491
<i>G.C. Dimitriou</i>	
Switch Level Automatic Test Pattern Generation	492
<i>E. El Madi, C. Landrault, and S. Pravossoudovitch</i>	
Testpattern Generation for Static CMOS Networks	494
<i>C. Engel-Winter and M. Schaefer</i>	
Modeling of VLSI-Circuits for Simulation and Testgeneration	496
<i>W. Geisselhardt, J. Froemberg, U. Moeller, and W. Mohrs</i>	
LISAS: Loops-Implemented Systolic Array Simulator	498
<i>H. Hellwagner and T. Mueller-W.</i>	

A Systolic Processor Chip Dedicated to the Shortest-Path Problem	500
<i>M.C. Huber</i>	
Full-Decompositions of Sequential Machines	502
<i>Y. Hou</i>	
SoS (Silicon Operating System): A Software Environment for VLSI Design	504
<i>A. LaCruz, M. Garijo, O. Nieto, and C. Lopez</i>	
An Electrical Switch-Level Simulator for MOS Digital Circuits	506
<i>P. Linardis and C. Krieb</i>	
Multigrid Method: An Efficient Numerical Tool in VLSI Process Modeling	508
<i>S. Mijalkovic and N. Stojadinovic</i>	
Use of a Multi-Paradigm AI Software Tool for Automated VLSI Design	510
<i>P.G. Paulin</i>	
Macromodeling and Macroanalysis of CMOS LSI Electronic Circuits	512
<i>P. Petkovic and V. Litovski</i>	
General Cell Placement Procedure for a UAHPL Based DA System	514
<i>S. Sait M.</i>	
A New Logic Simulator for MOS VLSI Circuits	516
<i>A.E. Salama and A.H. Khalil</i>	
An Improved Design of PLAs with CED and Offline Testing Capabilities	518
<i>R. Sharma and T.N. Rajashekhara</i>	
CHARM: A Knowledge-Based System for VLSI Chip-Architectures: A System's Perspective	520
<i>K.-H. Temme</i>	

3. MICROELECTRONICS AND VLSI: STATUS AND TRENDS

Microelectronics and VLSI: Status and Trends	522
<i>H. Ruechardt</i>	
Future VLSI Technology	
3D Integration Becoming a Reality?	523
<i>I. Ruge</i>	
Regular VLSI Structures	525
<i>E. Langheld</i>	
Wafer Scale Integration	
WSI: The Challenge of the Future	531
<i>J. Trilhe and G. Saucier</i>	
Reconfiguration Strategies for Yield Improvement of Complex Nodes in Wafer Scale Integration of 2D Processor Arrays	543
<i>P. Genestier and G. Saucier</i>	
Reconfiguration in WSI Arrays Using Minimum Spanning Trees	547
<i>F. Lombardi and D. Sciuto</i>	
Transmission Lines for Wafer Scale Integration	551
<i>H. Stopper</i>	
High Speed Digital	
Very High Speed Logic and Memory in SI Bipolar Technology	555
<i>W. Brackelmann</i>	
GaAs Digital ICs for Computer Applications	558
<i>M. Rocchi</i>	
Trends in VLSI Microprocessor Design	564
<i>D. Alpert, D. Biran, L. Epstein, J. Levy, B. Maytal, Y. Sidi, and U. Weiser</i>	

VLSI Packaging	
VLSI Packaging for Large General Purpose Computers	568
<i>D. Balderes and M.L. White</i>	
VLSI Packaging with High Density TAB Interconnect Tapes: New Design Guidelines	572
<i>A. Nanda</i>	
Semiconductor and Packaging Technologies: Aspects of Development and Manufacturing	578
<i>P. Ehret</i>	
Testing and Diagnostics	
New Concepts in VLSI Contactless Diagnostics	585
<i>H. Beha</i>	
A Fault-Tolerant Testable Module for Wafer Scale Integrated Systems	590
<i>M.A. Bayoumi and J.C.H. Yang</i>	
Testing Hybrid Circuits Using Digital Techniques	594
<i>J. Damianos and B.R. Wilkins</i>	
Integrated Electron Beam Measurement System for Automated Chip Verification	598
<i>G. Geiger, S. Goerlich, H. Harbeck, P. Kessler, E. Wolfgang, and K. Zibert</i>	
Advanced Design Concepts	
System Implementation on a Highly Structured VLSI Master Image	604
<i>G. Koetzle</i>	
New ASIC Concepts for Fast Prototyping Services	610
<i>J.-L. Grand-Clement</i>	
Physical Design I	
An Overview of Placement and Routing Techniques	615
<i>U. Lautner</i>	
Symbolic Based Layout Generation for BICMOS Designs	621
<i>R. Kessler and H.-U. Post</i>	
An Automatic/Interactive Placement and Routing System for Custom VLSI Layout Design	625
<i>H. Cai and A.J. van der Hoeven</i>	
Efficient Algorithms for Two- and Three-Layer Channel Routing	629
<i>J.M. Kleinhaus</i>	
Physical Design II	
Layout Synthesis Strategies in Silicon Compilation	633
<i>G.M. Bisio, D.D. Caviglia, and F. Curatelli</i>	
Routing Gate-Arrays on a Multiprocessor	637
<i>H. Burkhardt and H. Kindlimann</i>	
A Novel Placement Method for VLSI Design	642
<i>M. Razaz and J. Gan</i>	
Automatic Layout Transformation of Mask Layout to New Design-Rules	646
<i>H. Hartmann</i>	
Memories	
Evolution of DRAM in Silicon MOS Technology	650
<i>H. Iizuka, F. Horiguchi, S. Watanabe, and A. Hojo</i>	
Selfrepairing Semiconductor Memories	656
<i>O. Kowarik, R. Kraus, and K. Hoffmann</i>	

Design of Memory Chips for Resistance to Alpha-Particle-Induced Soft Errors	660
<i>P.M. Carter and B.R. Wilkins</i>	
A 50 MHz 8.256 CMOS Shift Register	664
<i>M. Bartel and O. Geisler</i>	
Production and Market Trends	
Digital IC Technologies: 1987-2000: Implications for Systems Suppliers and IC Manufacturers	668
<i>S.J. Nickel</i>	
An Approach to Satisfy Both High Integration and Economy in the VLSI Factory of the 90s	673
<i>M. Nakamura, S. Koguchi, and G. Inoue</i>	
The Requirements of the Computer Industry on Microelectronics	678
<i>H. Kiemle</i>	
VLSI Manufacturing as Tea Ceremony: Possible Foundations of Japanese Chip Quality	682
<i>R.A. Myers</i>	
Poster Session III	
A Wafer-Scale Architecture for Boundary Value Computations	686
<i>J.G. Delgado-Frias and D.M. Green</i>	
4. COMPUTER SYSTEMS: STATUS AND TRENDS	
Computer-Systems: Status and Trends	688
<i>D.C.J. Poortoliet</i>	
Systolic Array and Processors I	
Why Dynamic Pipelines for Systolic Systems?	689
<i>G. Pannierselvam</i>	
Nonplanar Array Processing	695
<i>J.L. Aravena and W.A. Porter</i>	
Solving Geometric Problems on a Two-Dimensional Systolic Array	699
<i>M. Lu and P. Varman</i>	
On-Line Error Detection and Reconfiguration of Array Processors with Two-Level Redundancy	703
<i>M. Wang, M. Cutler, and S.Y.H. Su</i>	
Systolic Array and Processors II	
High Speed Inversion of Dense Matrices on an Optimal Systolic Array	707
<i>A. El-Amawy</i>	
Systolic Arrays for Polynomial Quadratic Factors Computation	712
<i>O. Brudaru</i>	
Fault Detection in Partially Utilized Systolic Arrays	716
<i>H. Hellwagner</i>	
Fault-Tolerant Systolic Arrays for Antialiasing	720
<i>V. Beiu and C. Constantinescu</i>	
A "Zero-Time" Linear Systolic Array for Serial-Parallel Binary Multiplication Algorithm	724
<i>R. Charny and F.-C. Lin</i>	
Automation and Robotics	
Special Computers: Graphics, Robotics	727
<i>B. Yang, D. Timmermann, J.F. Boehme, H. Hahn, B.J. Hosticka, G. Schmidt, and G. Zimmer</i>	

Robotic Simulation by Bilinearization	731
<i>M.A. Hashish and O.S. Emam</i>	
Image Processing and Graphics	
Distributed Image Processing Systems	737
<i>D. Meyer-Ebrecht, Th. Schilling, B. Fasel, F. Vossebuenger, and W. Winkler</i>	
Advances in Computer Graphics and Image Processing	743
<i>P. Stucki</i>	
VLSI-Based Partially Ordered Tree for Storing 3-D Geometric Information in Data Base	746
<i>J. Skyttä and T. Takala</i>	
Parallel Computers for Realistic Image Synthesis (extended abstract)	750
<i>H. Mueller</i>	
Computer Networks I	
Artificial Intelligence in Communications Networks	754
<i>L.F. Pau</i>	
A Private Integrated Services Digital Network (ISDN) for the Interconnection and Interworking of Personal Computers	759
<i>J. van Remortel</i>	
Computer Networks II	
Impact of New Technologies on the Structure of Communication Systems	763
<i>M. Reiser</i>	
The Application of Code Division Multiplexing Techniques to Local Area Networks	767
<i>C.T. Spracklen and C. Smythe</i>	
A New Conception of Random-Access Multi-Channel Local Area Networks	771
<i>A.T. Kozłowski</i>	
Process Location Strategy in a LAN for Industrial Application	775
<i>L. Ciminiera, C. Demartini, and A. Valenzano</i>	
Parallel Processing/Multiprocessor Systems I	
Networks for Parallel Computers	779
<i>E.A.M. Odijk and R.A.H. van Twist</i>	
Tasks Creation and Distribution in the Dedicated Multimicroprocessor System	783
<i>V. Malbasu</i>	
Selecting the Interconnection Structure for Multiprocessor Systems	787
<i>D. Del Corso, F. Corno, and A. Daniele</i>	
Parallel Processing/Multiprocessor Systems II	
Design and Evaluation of a Modular Expandable Multiprocessor System	791
<i>R. Lauwereins and J.A. Peperstraete</i>	
Study of a Resource Arbitration-Interconnection Network for Multiprocessor Systems	797
<i>A. Pombortsis, P. Linardis, and C. Halatsis</i>	
Concurrent Execution of User and Diagnostic Tasks in a Computer System	801
<i>M. Kubale and H. Krawczyk</i>	
Trends in Distributed Process Control Systems	805
<i>D.E. Ventzas</i>	
Supercomputer I	
Next Generation Computer Systems	809
<i>B.J. Procter</i>	
Design of an Adaptable Pipeline Based on Transputers	815
<i>A. Basu</i>	

Supercomputing Based on Recirculative Information Flows	819
<i>B. Borovsky and P. Ivanova</i>	
Vectorisation of Circuit Simulator ESPICE for FPS-x64	823
<i>H. Hoepken</i>	
Supercomputer II	
Supercomputers at Universities, Status and Trends	827
<i>D. Haupt and W. Jüling</i>	
Impact of Prediction Accuracy on the Performance of a Pipeline Computer	832
<i>A. Basu</i>	
Communication Structures in Supercomputers	836
<i>N. Drescher</i>	
Optical Computers	840
<i>A.W. Lohmann</i>	
Intelligent Workstations	
Advances in Workstation Architectures	841
<i>G. Faerber</i>	
Intelligent Workstation for Control and Supervision of Industrial Processes:	
Software Aspects	847
<i>A. Ollero and R. Sanz</i>	
AI in Banking: Intelligent Workstations or Mainframes?	851
<i>L. Slahor</i>	
Multifunctional Workstations for CAD-Applications and Office Automation	856
<i>B. Sonne</i>	
Special Computer Application	
Networks of Memory Elements: A Processor for Industrial Piece-Parts Recognition	859
<i>M.H. Al-Muifraje</i>	
A Local Area Network for Office and Process Communications Using	
Personal Computers	864
<i>P. Burgey, H. Mahler, and F.R. Roth</i>	
Local Area Network to Support VLSI-Design	867
<i>R. Hagelauer, K. Ronge, G. Schiener, and D. Seitzer</i>	
Computational Geometry and VLSI	870
<i>F. Dehne</i>	
Poster Session IV	
Computer Simulation of Scattered Minefields	876
<i>S.K. Bhattacharyya</i>	
Q-bus Based Multiprocessor System	878
<i>A. Brodnik, S. Mavric, and R. Trobec</i>	
A Data Storage Module with Integrated Processing Functions	880
<i>W.A. Halang</i>	
The OSUIMPS Multiprocessor System	882
<i>M.S. Obaidat, J.M. Jagadeesh, and G.M. Clark</i>	
Data Flow Computer Models	884
<i>M. Ojstersek, V. Zumer, and P. Kokol</i>	
PCLUCIE: A Layout Editor for Personal Computer	886
<i>E. Pasero</i>	
A Solution of the Assignment Problem on a Systolic Array	888
<i>U. Schwiigelshohn and L. Thiele</i>	
Fault Detection and Location for Tree Array Processors	890
<i>S.Y.H. Su, M. Cutler, and M. Wang</i>	

5. SPECIAL COURSE: DESIGNING SYSTEMS WITH VLSI TODAY

Special Course on Designing Systems with VLSI Today	892
<i>E.H. Rothauser</i>	

Technology Transfer: A Specific Example

The Technology Transfer Institute as a Link Between Customer and Vendor	893
<i>R. Hagelauer</i>	
Technology Transfer: The Computerized Jogging Shoe	897
<i>F. Dassler</i>	

Continuing Engineering Education: Corporate Classroom or University Courses?

Corporate Classrooms	899
<i>E.T. Cranch</i>	
Open University Postgraduate Education in Microelectronics and the Industrial Uses of Computers	902
<i>D.J. Crecraft</i>	
Education in Industry: A Time of Transition	905
<i>B. Arnett</i>	

Design and Implementation Considerations

ASICs: A New Generation of Chips: Why and How to Use Them	909
<i>E. Kiel</i>	
Industrial Use of Modern Gate Arrays	911
<i>D. Holzmann</i>	
Experiences with Semi-Custom Chips	913
<i>H. Vogt</i>	

Migration into Microelectronics

New Technologies Require New Structures	916
<i>J. Loehn</i>	

Simulation and Testing

Testing: The Bottleneck of VLSI?	917
<i>W. Daehn</i>	
VLSI CAD/CAE Directions	920
<i>T.F. Wheeler</i>	

Reliability, Maintainability, and Availability

Reliability, Maintainability, Availability	925
<i>A. Birolini</i>	
Design for Reliability	927
<i>M.J.L. Giraud</i>	
Design for Maintainability	931
<i>M. Holy</i>	
VLSI Failure Mechanisms	937
<i>F. Fantini and M. Vanzi</i>	

Designing with CAD Tools

On the Use of Hierarchies in the MIMOLA Hardware Design System	944
<i>P. Marwedel</i>	